Si5418DU

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Vishay Siliconix

## N-Channel 30 V (D-S) MOSFET

## PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Single





Marking code: Al

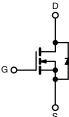
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	30				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = 10 V	0.0145				
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS}$ = 4.5 V	0.0185				
Q <sub>g</sub> typ. (nC)	9.5				
I <sub>D</sub> (A) <sup>a</sup>	12				
Configuration	Single				

#### **FEATURES**

- TrenchFET<sup>®</sup> power MOSFET
- Thermally enhanced PowerPAK® ChipFET package
  - Small footprint area
  - Low on-resistance
  - Thin 0.8 mm profile
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

#### **APPLICATIONS**

- · Load switch, PA switch, and battery switch for portable applications
- DC/DC synchronous rectification



N-Channel MOSFET

ORDERING INFORMATION				
Package PowerPAK ChipFET				
Lead (Pb)-free and halogen-free	Si5418DU-T1-GE3			

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_A = 25 \text{ °C}$ , unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V <sub>DS</sub>	30	V	
Gate-source voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		12 ª		
Continuous drain surront (T - 150 °C)	T <sub>C</sub> = 70 °C	1 .	12 <sup>a</sup>		
Continuous drain current ( $T_J = 150 \ ^\circ C$ )	T <sub>A</sub> = 25 °C	I <sub>D</sub>	11.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	9.3 <sup>b, c</sup>	A	
Pulsed drain current		I <sub>DM</sub>	40		
Constinuence of the divide of the second	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
Continuous source-drain diode current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	2.6 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		31		
	T <sub>C</sub> = 70 °C		20		
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C	1	2 <sup>b, c</sup>		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) d, e			260	°C	

### THERMAL RESISTANCE RATINGS

	a o				
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 5 s	R <sub>thJA</sub>	34	40	°C/W
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	3	4	0/10

Notes

a. Package limited b. Surface mounted on 1" x 1" FR4 board

c. t = 5 s

See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed d. and is not required to ensure adequate bottom side solder interconnection

Rework conditions: manual soldering with a soldering iron is not recommended for leadless components e.

f. Maximum under steady state conditions is 90 °C/W

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RoHS

COMPLIANT

HALOGEN

FREE

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Si5418DU

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	30	-	-	V		
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_J$		40	-	m\//°C		
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-7	-	mV/°C		
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1.2	-	3	V		
Gate-source leakage	I <sub>GSS</sub>	$V_{DS}=0~V,~V_{GS}=\pm~20~V$	-	-	± 100	nA		
Zero gete veltege drein ourrent	1	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA		
Zero gate voltage drain current	IDSS	$V_{DS}$ = 30 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 $^{\circ}C$	-	-	10			
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \geq 5 \text{ V},  V_{GS} = 10 \text{ V}$	20	-	-	Α		
Drain course on state registence à	В	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 7.7 \text{ A}$	-	0.0120	0.0145			
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6.9 \text{ A}$	-	0.0150	0.0185	Ω		
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 7.7 \text{ A}$	-	31	-	S		
Dynamic <sup>b</sup>								
Input capacitance	C <sub>iss</sub>		-	1350	-			
Output capacitance	C <sub>oss</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 0 V, f = 1 MHz	-	190	-	pF		
Reverse transfer capacitance	C <sub>rss</sub>		-	80	-			
Total gate charge	Qg	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 11.6 \text{ A}$	-	20	30	nC		
			-	9.5	15			
Gate-source charge	Q <sub>gs</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 11.6 A	-	4.5	-			
Gate-drain charge	Q <sub>gd</sub>		-	2.7	-			
Gate resistance	R <sub>g</sub>	f = 1 MHz	-	3.5	-	Ω		
Turn-on delay time	t <sub>d(on)</sub>		-	20	30	_		
Rise time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 1.6 \Omega, \text{ I}_{D} \cong 9.3 \text{ A},$	-	10	15			
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$	-	20	30			
Fall time	t <sub>f</sub>		-	10	15			
Turn-on delay time	t <sub>d(on)</sub>		-	10	15	ns		
Rise time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 1.6 $\Omega$ , $I_D \cong$ 9.3 A,	-	10	15			
Turn-off delay time	t <sub>d(off)</sub>	$V_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$	-	20	30			
Fall time	t <sub>f</sub>		-	10	15			
Drain-Source Body Diode Characterist	ics							
Continuous source-drain diode current	IS	T <sub>C</sub> = 25 °C	-	-	12			
Pulse diode forward current	I <sub>SM</sub>		-	-	40	A		
Body diode voltage	V <sub>SD</sub>	$I_{\rm S} = 9.3$ A, $V_{\rm GS} = 0$ V	-	0.8	1.2	V		
Body diode reverse recovery time	t <sub>rr</sub>		-	25	40	ns		
Body diode reverse recovery charge	Q <sub>rr</sub>	I <sub>F</sub> = 9.3 A, di/dt = 100 A/μs,	-	19	30	nC		
Reverse recovery fall time	ta	$T_{\rm J} = 25 \ ^{\circ}{\rm C}$	-	14	-			
Reverse recovery rise time t <sub>b</sub>			-	11	-	ns		

Notes

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %

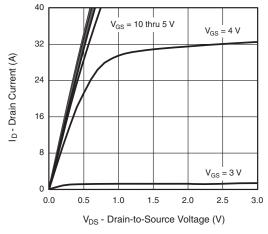
b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

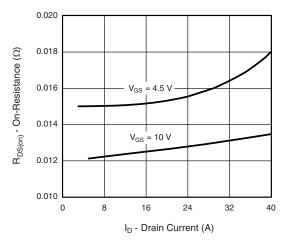
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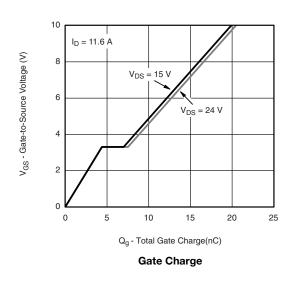
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

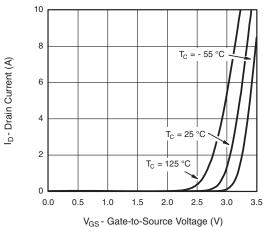


**Output Characteristics** 



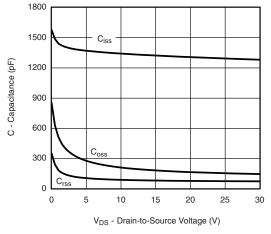
**On-Resistance vs. Drain Current and Gate Voltage** 



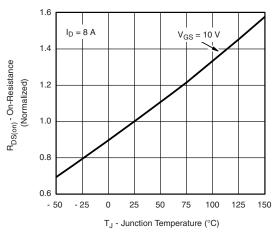


Transfer Characteristics









**On-Resistance vs. Junction Temperature** 

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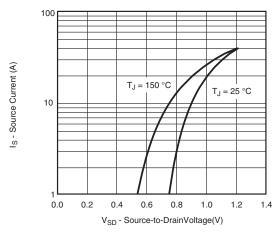
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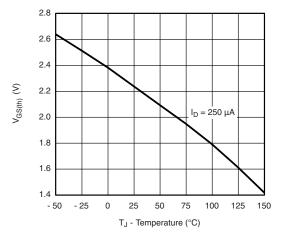
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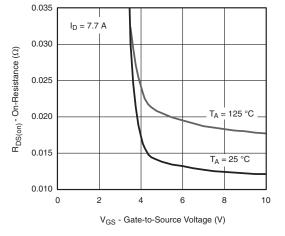
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



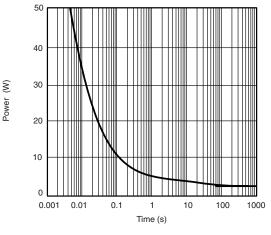
Source-Drain Diode Forward Voltage



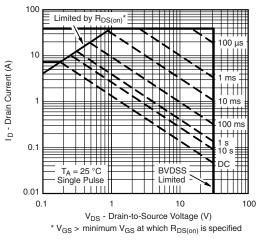




**On-Resistance vs. Gate-to-Source Voltage** 



Single Pulse Power, Junction-to-Ambient

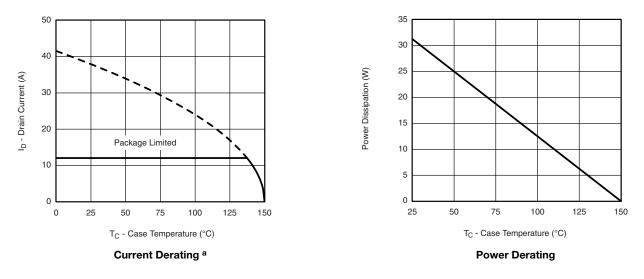


Safe Operating Area, Junction-to-Ambient

4



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

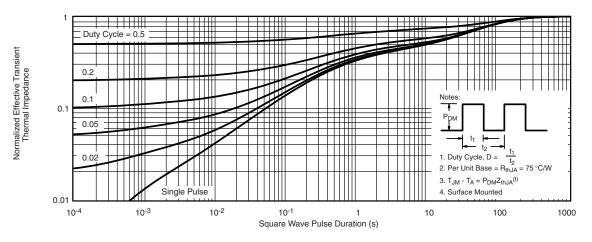


#### Note

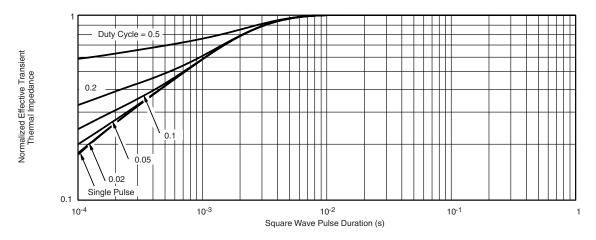
a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

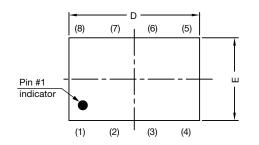
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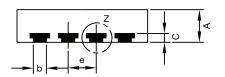
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# PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Case Outline

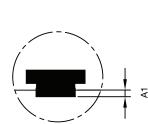




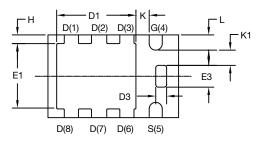


Side view of dual

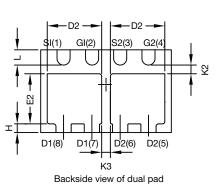
Side view of single



Detail Z



## Backside view of single pad



DIM.		MILLIMETERS			INCHES		
DIN.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
А	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC			0.026 BSC		
Н	0.15	0.20	0.25	0.006	0.008	0.010	
К	0.25	-	-	0.010	-	-	
K1	0.30	-	-	0.012	-	-	
K2	0.20	-	-	0.008	-	-	
K3	0.20	-	-	0.008	-	-	
L	0.30	0.35	0.40	0.012	0.014	0.016	
C14-0630-Rev. E DWG: 5940	, 21-Jul-14						

#### Note

• Millimeters will govern

Revision: 21-Jul-14

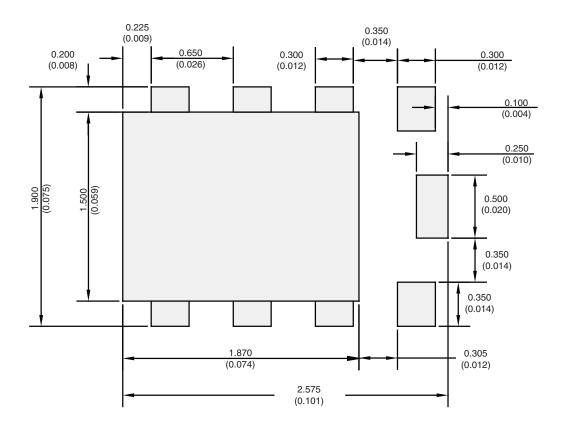
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# Application Note 826 Vishay Siliconix

## RECOMMENDED MINIMUM PADS FOR PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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